

PHP45N03LT; PHB45N03LT; PHD45N03LT

N-channel TrenchMOS transistor

Rev. 06 — 05 October 2000

Product specification

1. Description

N-channel logic level field-effect power transistor in a plastic package using TrenchMOS™¹ technology.

Product availability:

PHP45N03LT in SOT78 (TO-220AB)

PHB45N03LT in SOT404 (D²-PAK)

PHD45N03LT in SOT428 (D-PAK).

2. Features

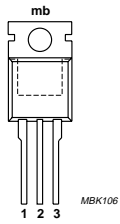
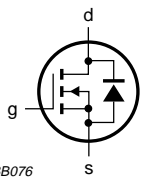
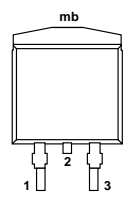
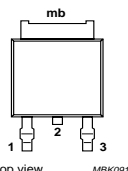
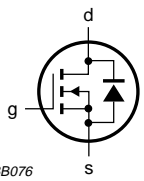
- Low on-state resistance
- Fast switching.

3. Applications

- Computer motherboard DC to DC converters
- Switched mode power supplies.

4. Pinning information

Table 1: Pinning - SOT78, SOT404, SOT428 simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1	gate (g)		
2	drain (d) [1]		
3	source (s)		
mb	mounting base, connected to drain (d)	 	
		SOT78 (TO-220AB) SOT404 (D²-PAK) SOT428 (D-PAK)	

[1] It is not possible to make connection to pin 2 of the SOT404 or SOT428 packages.

1. TrenchMOS is a trademark of Royal Philips Electronics.



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5. Quick reference data

Table 2: Quick reference data

Symbol	Parameter	Conditions	Typ	Max	Unit
V_{DS}	drain-source voltage (DC)	$T_j = 25$ to 175 °C	–	25	V
I_D	drain current (DC)	$T_{mb} = 25$ °C; $V_{GS} = 5$ V	–	45	A
P_{tot}	total power dissipation	$T_{mb} = 25$ °C	–	86	W
T_j	junction temperature		–	175	°C
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10$ V; $I_D = 25$ A	16	21	mΩ
		$V_{GS} = 5$ V; $I_D = 25$ A	20	24	mΩ

6. Limiting values

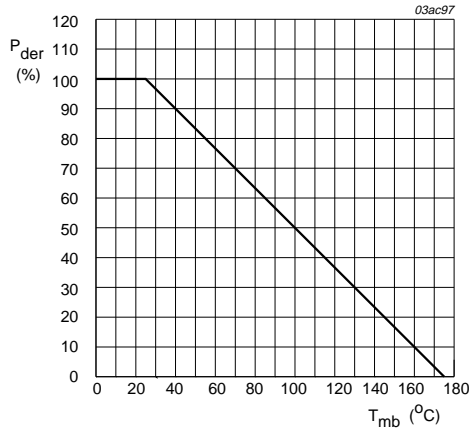
Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	$T_j = 25$ to 175 °C	–	25	V
V_{DGR}	drain-gate voltage (DC)	$T_j = 25$ to 175 °C; $R_{GS} = 20$ kΩ	–	25	V
V_{GS}	gate-source voltage (DC)		–	±15	V
I_D	drain current (DC)	$T_{mb} = 25$ °C; $V_{GS} = 5$ V; Figure 2 and 3	–	45	A
		$T_{mb} = 100$ °C; $V_{GS} = 5$ V; Figure 2	–	30	A
I_{DM}	peak drain current	$T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ μs; Figure 3	–	180	A
P_{tot}	total power dissipation	$T_{mb} = 25$ °C; Figure 1	–	86	W
T_{stg}	storage temperature		–55	+175	°C
T_j	operating junction temperature		–55	+175	°C

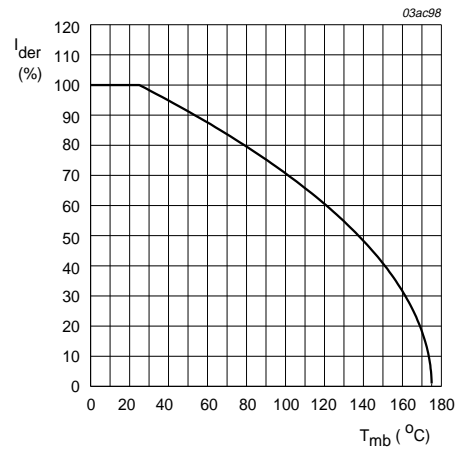
Source-drain diode

I_S	source (diode forward) current (DC)	$T_{mb} = 25$ °C	–	45	A
I_{SM}	peak source (diode forward) current	$T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ μs	–	180	A



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

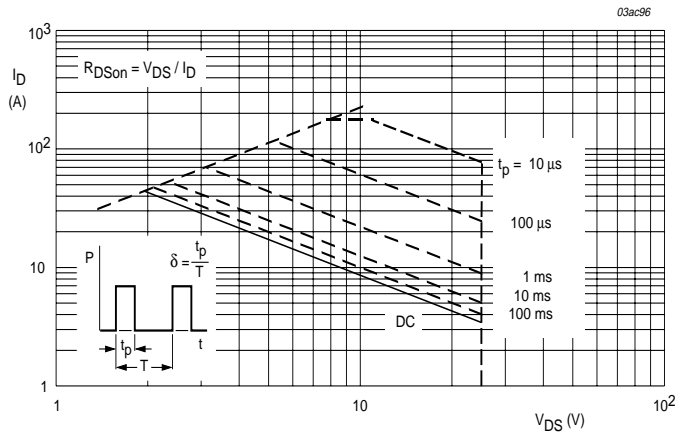
Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$$V_{GS} \geq 5V$$

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



$T_{mb} = 25^{\circ}C$; I_{DM} is single pulse.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

7. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Value	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 4	1.75	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in still air; SOT78 package	60	K/W
		mounted on a printed circuit board; minimum footprint; SOT404 and SOT428 packages	50	K/W

7.1 Transient thermal impedance

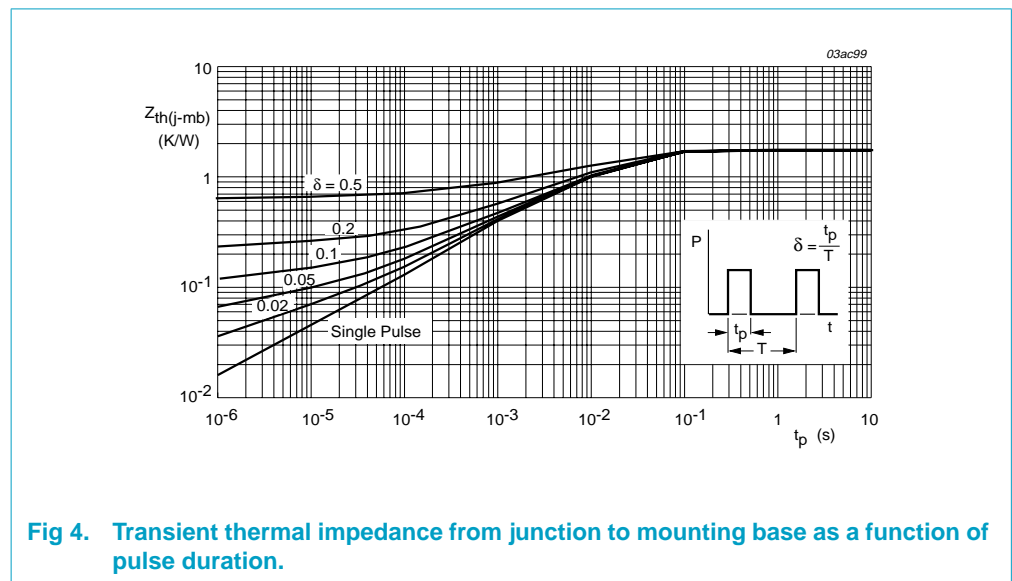
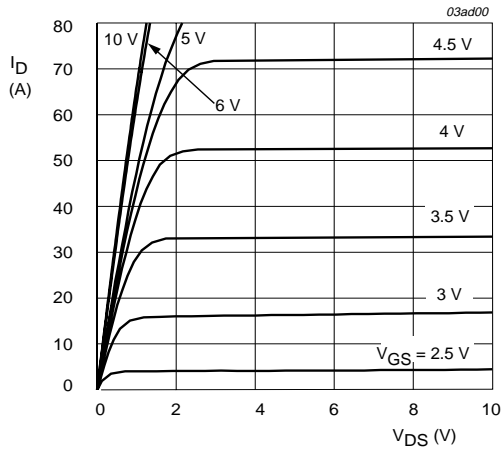


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

8. Characteristics

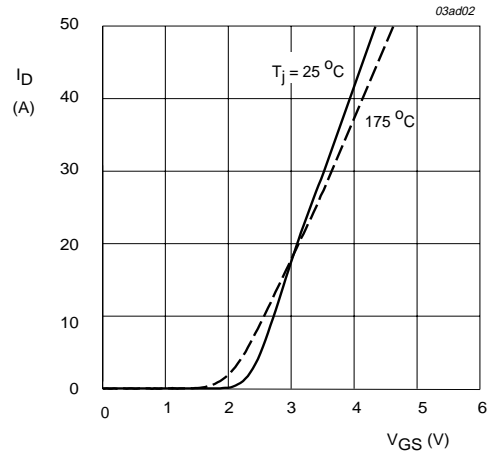
Table 5: Characteristics
 $T_j = 25\text{ °C}$ unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
Static characteristics							
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 0.25\text{ mA}; V_{GS} = 0\text{ V}$					
		$T_j = 25\text{ °C}$	25	–	–	V	
		$T_j = -55\text{ °C}$	22	–	–	V	
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1\text{ mA}; V_{DS} = V_{GS};$ Figure 9					
		$T_j = 25\text{ °C}$	1	1.5	2	V	
		$T_j = 175\text{ °C}$	0.5	–	–	V	
		$T_j = -55\text{ °C}$	–	–	2.3	V	
I_{DSS}	drain-source leakage current	$V_{DS} = 25\text{ V}; V_{GS} = 0\text{ V}$					
		$T_j = 25\text{ °C}$	–	0.05	10	μA	
		$T_j = 175\text{ °C}$	–	–	500	μA	
I_{GSS}	gate-source leakage current	$V_{GS} = \pm 5\text{ V}; V_{DS} = 0\text{ V}$	–	10	100	nA	
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 5\text{ V}; I_D = 25\text{ A};$ Figure 7 and 8					
		$T_j = 25\text{ °C}$	–	20	24	m Ω	
		$T_j = 175\text{ °C}$	–	–	45	m Ω	
		$V_{GS} = 10\text{ V}; I_D = 25\text{ A};$					
		$T_j = 25\text{ °C}$	–	–	21	m Ω	
Dynamic characteristics							
g_{fs}	forward transconductance	$V_{DS} = 25\text{ V}; I_D = 25\text{ A}$ Figure 11	8	16	–	S	
$Q_{g(tot)}$	total gate charge	$I_D = 45\text{ A}; V_{DD} = 15\text{ V};$	–	35	–	nC	
Q_{gs}	gate-source charge	$V_{GS} = 10\text{ V};$ Figure 14	–	5	–	nC	
Q_{gd}	gate-drain (Miller) charge		–	13	–	nC	
C_{iss}	input capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 25\text{ V};$	–	920	1100	pF	
C_{oss}	output capacitance	$f = 1\text{ MHz};$ Figure 12	–	260	310	pF	
C_{rss}	reverse transfer capacitance		–	180	220	pF	
$t_{d(on)}$	turn-on delay time	$V_{DD} = 15\text{ V}; I_D = 25\text{ A};$	–	6	7	ns	
t_r	turn-on rise time	$V_{GS} = 5\text{ V}; R_G = 5\text{ }\Omega;$ resistive load	–	40	48	ns	
$t_{d(off)}$	turn-off delay time		–	78	84	ns	
t_f	turn-off fall time		–	46	52	ns	
Source-drain diode							
V_{SD}	source-drain (diode forward) voltage	$I_S = 25\text{ A}; V_{GS} = 0\text{ V};$ Figure 13	–	0.95	1.2	V	
		$I_S = 40\text{ A}; V_{GS} = 0\text{ V}$	–	1.0	–	V	
t_{rr}	reverse recovery time	$I_S = 40\text{ A};$	–	52	–	ns	
Q_r	recovered charge	$dI_S/dt = -100\text{ A}/\mu\text{s};$ $V_{GS} = 0\text{ V}; V_{DS} = 25\text{ V}$	–	0.08	–	μC	



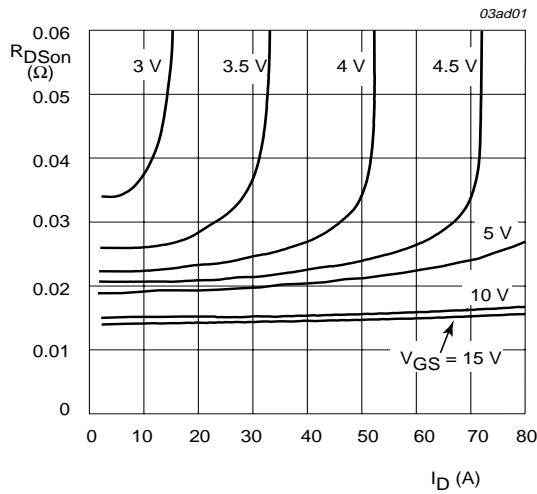
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



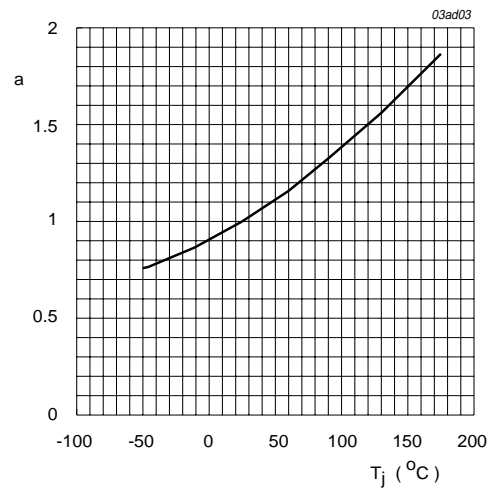
$T_j = 25\text{ }^\circ\text{C}$ and $175\text{ }^\circ\text{C}$; $V_{DS} = 25\text{ V}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



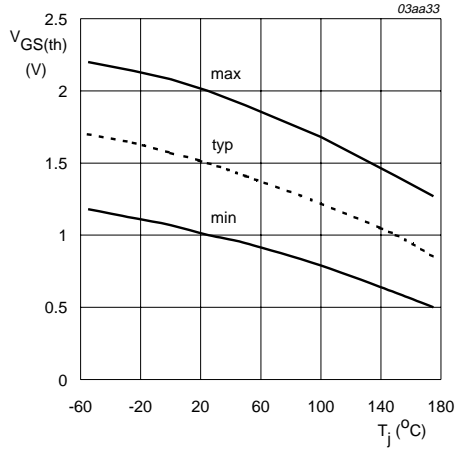
$T_j = 25\text{ }^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



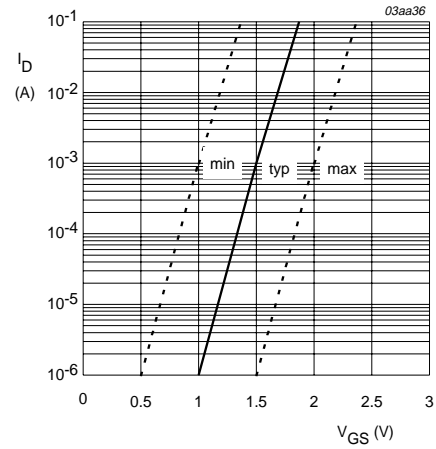
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



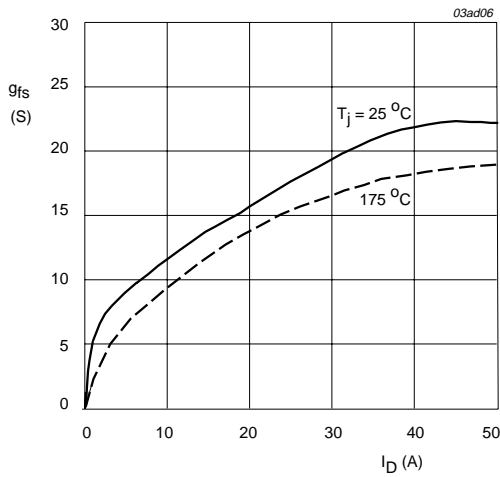
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



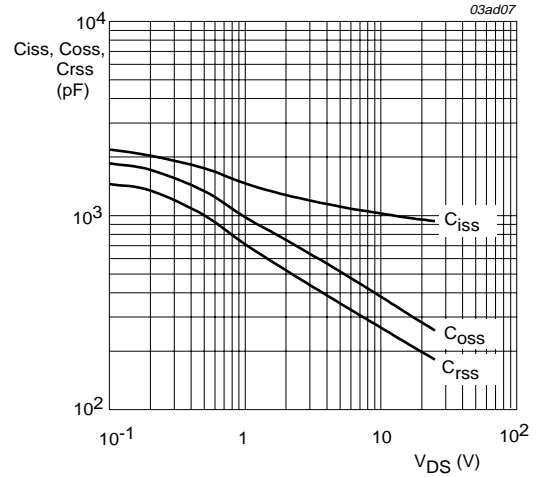
$T_j = 25 \text{ }^\circ\text{C}; V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



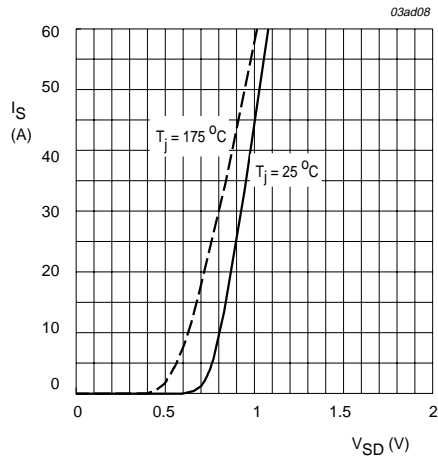
$T_j = 25 \text{ }^\circ\text{C and } 175 \text{ }^\circ\text{C}; V_{DS} > I_D \times R_{DSon}$

Fig 11. Forward transconductance as a function of drain current; typical values.



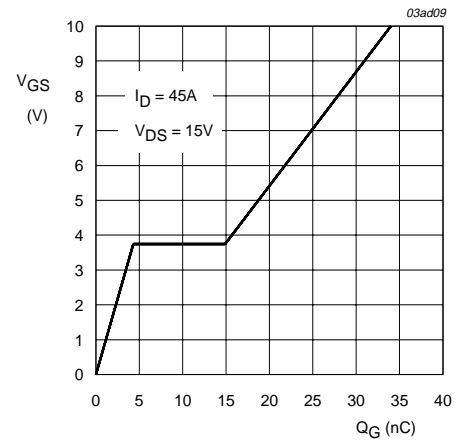
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



$T_j = 25^\circ\text{C}$ and 175°C ; $V_{GS} = 0\text{ V}$

Fig 13. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



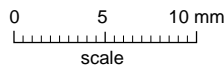
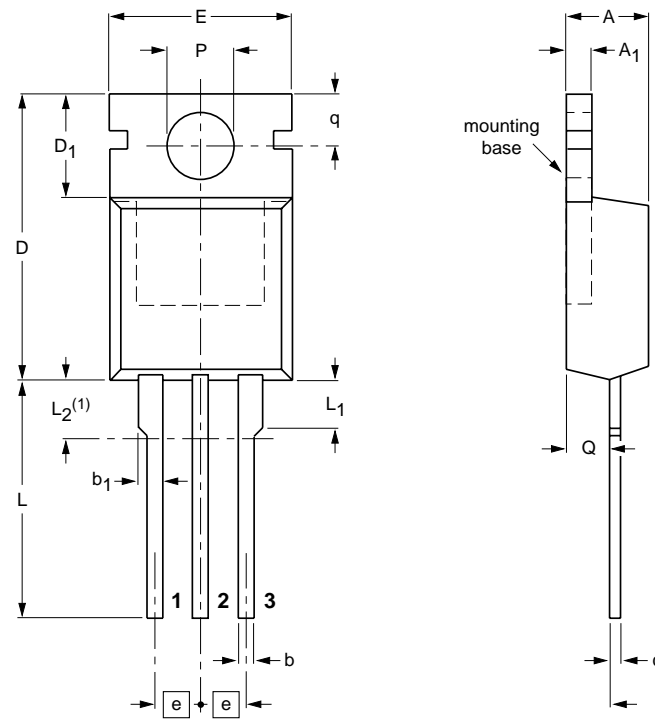
$I_D = 45\text{ A}$; $V_{DS} = 15\text{ V}$

Fig 14. Gate-source voltage as a function of gate charge; typical values.

9. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78



DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	b	b ₁	c	D	D ₁	E	e	L	L ₁	L ₂ ⁽¹⁾ max.	P	q	Q
mm	4.5 4.1	1.39 1.27	0.9 0.7	1.3 1.0	0.7 0.4	15.8 15.2	6.4 5.9	10.3 9.7	2.54	15.0 13.5	3.30 2.79	3.0	3.8 3.6	3.0 2.7	2.6 2.2

Note

1. Terminals in this zone are not tinned.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT78		3-lead TO-220AB	SC-46			99-09-13 00-09-07

Fig 15. SOT78 (TO-220AB).

Plastic single-ended surface mounted package (Philips version of D²-PAK); 3 leads
(one lead cropped)

SOT404



Fig 16. SOT404 (D²-PAK)

Plastic single-ended surface mounted package (Philips version of D-PAK); 3 leads
(one lead cropped)

SOT428

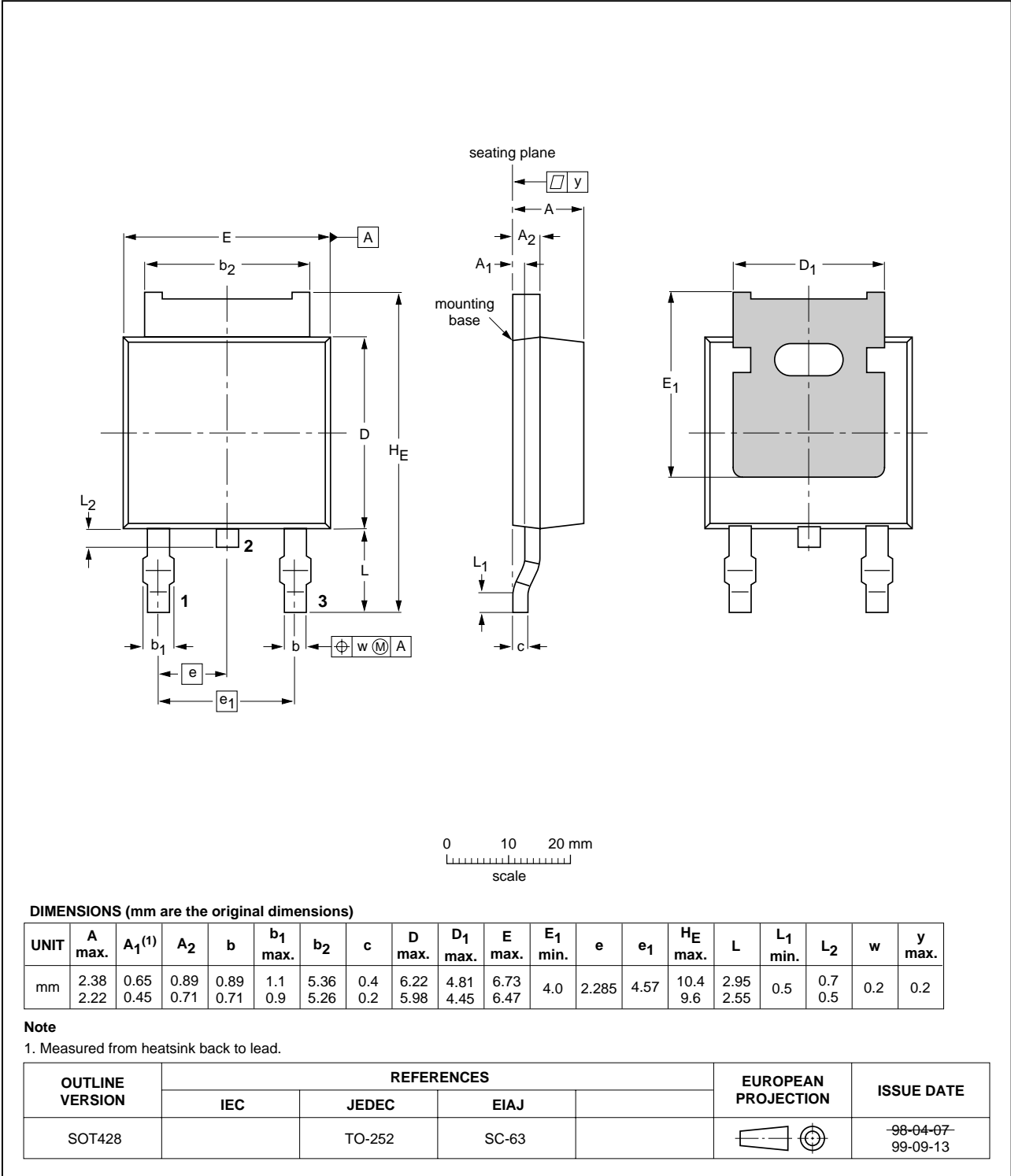


Fig 17. SOT428 (D-PAK)

10. Revision history

Table 6: Revision history

Rev	Date	CPCN	Description
06	20001005	-	Supersedes Rev. 05; reformatted; dynamic characteristics improved.
05	20000524	-	Supersedes Rev. 04 (archived)
04	19980601	-	Supersedes Rev. 03 (archived)
03	19980101	-	Supersedes Rev. 02 (archived)
02	19970609	-	Supersedes Rev. 01 (archived)
01	19971121	-	Product specification

11. Data sheet status

Datasheet status	Product status	Definition ^[1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

[1] Please consult the most recently issued data sheet before initiating or completing a design.

12. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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